



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,303	HUTCHENS ET AL.	
Examiner	Art Unit	
David J. Venci	1641	

	SEARCHED			
Class	Class Subclass Date		Examiner	
435	174,175,1 76,177,17 8,179,180	5/25/2006	DV	
435	181,182	5/25/2006	DV	
435	187,188	5/25/2006	DV	
435	287.1	5/25/2006	DV	
435	287.2	5/25/2006	DV	
435	287.7	5/25/2006	DV	
435	287.9	5/25/2006	DV	
435	288.3	5/25/2006	DV	
435	288.4	5/25/2006	DV	
435	288.6	5/25/2006	DV	
435	803,814	5/25/2006	DV	
435	815,970	5/25/2006	DV	
435	973	5/25/2006	DV	
435	DIG.45	5/25/2006	DV	

INT	INTERFERENCE SEARCHED		
Class Subclass		Date	Examiner
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updated (s	see above)	5/25/2006	DV

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EASTWEST	5/25/2006	DV
PUBMED	5/25/2006	DV
SCIENCEDIRECT	5/25/2006	DV
STN - see attached	5/25/2006	DV
PALM - inventor name search	5/25/2006	DV
Patentability Conference - Long Le (SPE 1641), Bruce Campbell (SPE 1648)	5/25/2006	DV

Search Notes (continued)



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Class Subclass		Date	Examiner	
436	518,523,5 24,525,52 6,527,528	5/25/2006	DV	
436	529,530	5/25/2006	DV	
436	531,532	5/25/2006	DV	
436	535,161	5/25/2006	DV	
436	162,173	5/25/2006	DV	
436	174,175	5/25/2006	DV	
436	176,177	5/25/2006	DV	
436	178,809	5/25/2006	DV	
436	825	5/25/2006	DV	
422	69,70,78	5/25/2006	DV	
422	80,186.01	5/25/2006	DV	
422	186.02	5/25/2006	DV	
422	236,906	5/25/2006	DV	
422	942,946	5/25/2006	DV	

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Class Subclass		Date	Examiner	
				

SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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Search Notes (continued)



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Class	Class Subclass		Examiner	
422	947,948	5/25/2006	DV	
210	660,663	5/25/2006	DV	
210	695	5/25/2006	DV	
204	157.15	5/25/2006	DV	
204	546	5/25/2006	DV	
204	403.01	5/25/2006	DV	
204	403.03	5/25/2006	DV	
204	403.04	5/25/2006	DV	
250	281,282	5/25/2006	DV	
250	288	5/25/2006	DV	
530	413,416	5/25/2006	DV	
118	102,624	5/25/2006	DV	
118	717	5/25/2006	DV	
427	2.13,466	5/25/2006	DV	

INT	INTERFERENCE SEARCHED			
Class Subclass		Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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Search Notes (continued)



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Class	Subclass Date		Examiner		
427	504,510,5 26,97.3,98 .4,184,256	5/25/2006	DV		
427	261,279	5/25/2006	DV		
427	448,552	5/25/2006	DV		
427	555	5/25/2006	DV		
977	703,704	5/25/2006	DV		
977	705,706	5/25/2006	DV		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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